

| <b>Issue Classification</b>  | Application/Control No. | Applicant(s)/Patent Under Reexamination |
|--|-------------------------|---|
|  | 10617026                | LEE ET AL.                              |
| Barcode  | Examiner                | Art Unit                                |
|  | Moon, Seokyun           | 2629                                    |

|  |                      |                          |                                    |
|--|----------------------|--------------------------|------------------------------------|
| Moon, Seokyun<br>(Assistant Examiner)        | 07/07/2008<br>(Date) |                          | <b>Total Claims Allowed:</b><br>19 |
| /Sumati Lefkowitz/ SPE<br>(Primary Examiner) | 7/9/08<br>(Date)     | O.G. Print Claim(s)<br>1 | O.G. Print Figure<br>1             |